

FJP5355

High Voltage Switch Mode Application

- High Speed Switching
- Very Low Switching Losses
- Very Low Operating Temperature
- Wide RBSOA



1.Base 2.Collector 3.Emitter

NPN Silicon Transistor

Absolute Maximum Ratings T_C=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collector-Base Voltage	900	V
V _{CEO}	Collector-Emitter Voltage	440	V
V _{EBO}	Emitter- Base Voltage	14.5	V
I _C	Collector Current (DC)	5	Α
I _{CP}	Collector Current (Pulse)	7.5	Α
I _B	Base Current	2.5	Α
P _C	Collector Dissipation (T _C =25°C)	50	W
TJ	Junction Temperature	150	°C
T _{STG}	Storage Temperature	- 65 ~ 150	°C

Electrical Characteristics $T_C=25$ °C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV _{CBO}	Collector- Base Breakdown Voltage	$I_C = 500 \mu A, I_E = 0$	900			V
BV _{CEO}	Collector- Emitter Breakdown Voltage	$I_{C} = 5mA, I_{B} = 0$	440			V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_E = 500 \mu A, I_C = 0$	14.5			V
I _{EBO}	Emitter Cut-off Current	$V_{EB} = 12V, I_{C} = 0$			1	μΑ
h _{FE}	*DC Current Gain	$V_{CE} = 2V, I_{C} = 10mA$	15			
		$V_{CE} = 2V, I_{C} = 0.8A$	15			
		$V_{CE} = 2V, I_{C} = 2.5A$	7			
V _{CE} (sat)	*Collector-Emitter Saturation Voltage	$I_C = 0.8A, I_B = 0.2A$			0.2	V
		$I_C = 2.5A, I_B = 0.8A$			0.4	V
V _{BE} (sat)	*Base-Emitter Saturation Voltage	$I_C = 0.8A, I_B = 0.2A$			1.0	V
		$I_C = 2.5A, I_B = 0.8A$			1.2	V
f _T	Current Gain Bandwidth Product	$V_{CE} = 10V, I_{C} = 0.2A$	4			MHz
t _{ON}	Turn On Time	$V_{CC} = 125V, I_{C} = 0.5A$			1.1	μs
t _{STG}	Storage Time	$I_{B1} = 45\text{mA}, -I_{B2} = 0.5\text{A}$			1.2	μs
t _F	Fall Time	PW=300μs			0.4	μs

^{*} Pulse test: PW≤300μs, Duty cycle≤2%

Typical Characteristics

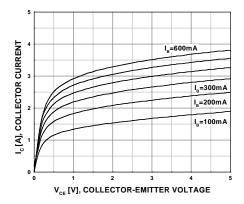


Figure 1. Static Characteristic

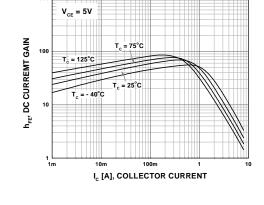


Figure 2. DC Current Gain

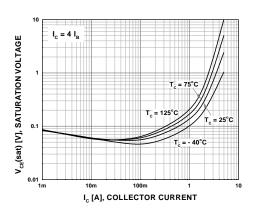


Figure 3. Saturation Voltage

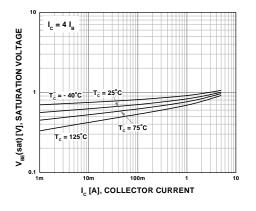


Figure 4. Saturation Voltage

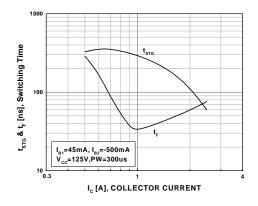


Figure 5. Resistive Load Switching

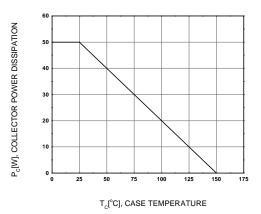
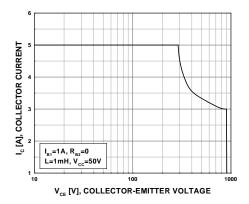
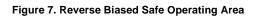


Figure 6. Power Derating Curve

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Typical Characteristics (Continued)





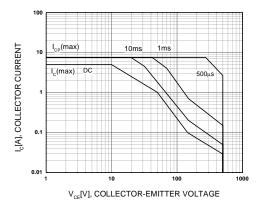
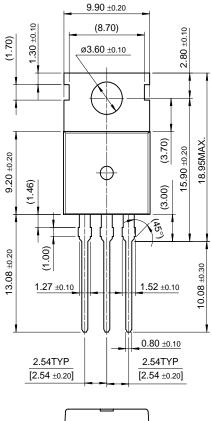
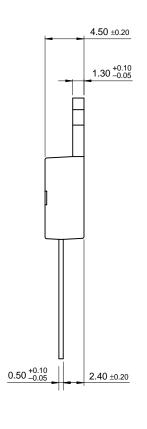


Figure 8. Forward Biased Safe Operating Area

Package Dimensions

TO-220





10.00 ±0.20

Dimensions in Millimeters

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